

## 24A, 200V N-CHANNEL MOSFET

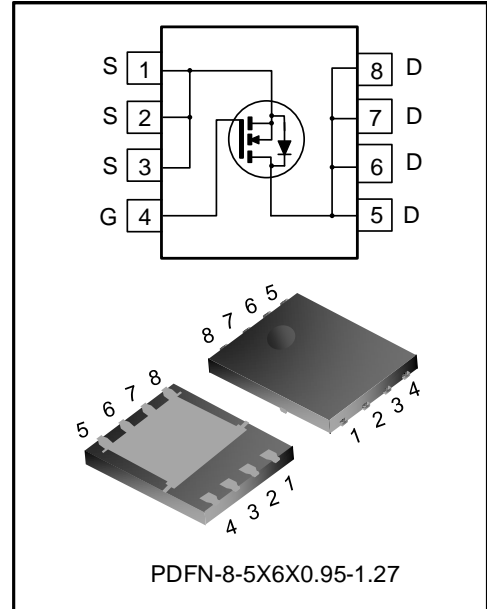
### DESCRIPTION

SVGP20500NL5 is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in power management for UPS and Inverter Systems.

### FEATURES

- ◆ 24A, 200V,  $R_{DS(on)(typ.)}=42m\Omega @ V_{GS}=10V$
- ◆ Low gate charge
- ◆ Low  $C_{rss}$
- ◆ Fast switching
- ◆ Extreme  $dv/dt$  rated
- ◆ 100% avalanche tested
- ◆ Pb-free lead plating
- ◆ RoHS compliant



### KEY PERFORMANCE PARAMETERS

Characteristics	Ratings	Unit
$V_{DS}$	200	V
$V_{GS(th)}$	2.0~4.0	V
$R_{DS(on),max.}$	50	$m\Omega$
$I_D$	24	A
$Q_{g,typ.}$	20	nC

### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVGP20500NL5TR	PDFN-8-5X6X0.95-1.27	P20500NL5	Halogen free	Tape & Reel

**ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED,  $T_J=25^{\circ}\text{C}$ )**

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Voltage	$V_{DS}$	--	200	--	--	V
Gate-source Voltage	$V_{GS}$	--	-20	--	20	V
Drain Current (Note 1)	$I_D$	$T_C=25^{\circ}\text{C}$	--	--	24	A
		$T_C=100^{\circ}\text{C}$	--	--	15	A
Drain Current Pulsed (Note 2)	$I_{DM}$	$T_C=25^{\circ}\text{C}$	--	--	96	A
Power Dissipation (Note 3)	$P_D$	$T_C=25^{\circ}\text{C}$	--	--	89	W
Single Pulsed Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}$ , $V_{DD}=80\text{V}$ , $R_G=25\Omega$ , starting temperature $T_J=25^{\circ}\text{C}$	--	--	29	mJ
Single Pulsed Avalanche Current	$I_{AS}$	--	--	--	24	A
Operation Junction Temperature Range	$T_J$	--	-55	--	150	$^{\circ}\text{C}$
Storage Temperature Range	$T_{stg}$	--	-55	--	150	$^{\circ}\text{C}$

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Thermal Resistance, Junction-case, Bottom	$R_{\theta JC}$	--	--	--	1.4	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-ambient	$R_{\theta JA}$	--	--	--	50	$^{\circ}\text{C/W}$
Soldering Temperature (SMD)	$T_{sold}$	Reflow soldering: $10 \pm 1\text{sec}$ , 3times	--	--	260	$^{\circ}\text{C}$

## ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, $T_J=25^{\circ}\text{C}$ )

### Static characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Drain-source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	200	--	--	V
Drain-source Leakage Current	$I_{DSS}$	$V_{DS}=200V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	--	--	1.0	$\mu A$
		$V_{DS}=200V, V_{GS}=0V, T_J=125^{\circ}\text{C}$	--	6.0	--	
Gate-source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	--	4.0	V
Static Drain-source On State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=22A$	--	42	50	$m\Omega$
Gate Resistance	$R_g$	$f=1\text{MHz}$	--	5.19	--	$\Omega$

### Dynamic characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Input Capacitance	$C_{iss}$	$f=1\text{MHz}, V_{GS}=0V, V_{DS}=100V$	--	1225	--	pF
Output Capacitance	$C_{oss}$		--	96	--	
Reverse Transfer Capacitance	$C_{rss}$		--	6.3	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=100V, V_{GS}=10V, R_G=6\Omega, I_D=12A$ (Notes 4, 5)	--	11	--	ns
Turn-on Rise Time	$t_r$		--	26	--	
Turn-off Delay Time	$t_{d(off)}$		--	34	--	
Turn-off Fall Time	$t_f$		--	22	--	
Total Gate Charge	$Q_g$	$V_{DD}=100V, V_{GS}=10V, I_D=12A$ (Notes 4, 5)	--	20	--	nC
Gate-source Charge	$Q_{gs}$		--	8.5	--	
Gate-drain Charge	$Q_{gd}$		--	4.6	--	
Gate-plateau Voltage	$V_{plateau}$		--	5.4	--	V

### Reverse diode characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
			Min.	Typ.	Max.	
Continuous Diode Forward Current	$I_S$	$T_C=25^{\circ}\text{C}$ , integral reverse P-N junction diode in the MOSFET	--	--	24	A
Diode Pulse Current	$I_{S,pulse}$		--	--	96	
Reverse Recovery Time	$V_{SD}$	$I_S=22A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Charge	$T_{rr}$	$I_S=12A, V_{GS}=0V,$	--	85	--	ns
Reverse Recovery Peak Current	$Q_{rr}$	$dI_F/dt=100A/\mu s$ (Note 4)	--	0.31	--	$\mu C$

### Notes:

- The rated value only refers to the maximum absolute value at the case temperature of  $25^{\circ}\text{C}$  in the specification. If the case temperature is higher than  $25^{\circ}\text{C}$ , it should be derated according to the actual environmental conditions;
- Pulse time  $5\mu s$ , pulse width is limited by the maximum junction temperature;
- The dissipation power will change with temperature, derating above  $25^{\circ}\text{C}$ :  $0.7W/^{\circ}\text{C}$ ;
- Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ ;
- Essentially independent of operating temperature.

## TYPICAL CHARACTERISTICS

Figure 1. Output Characteristics

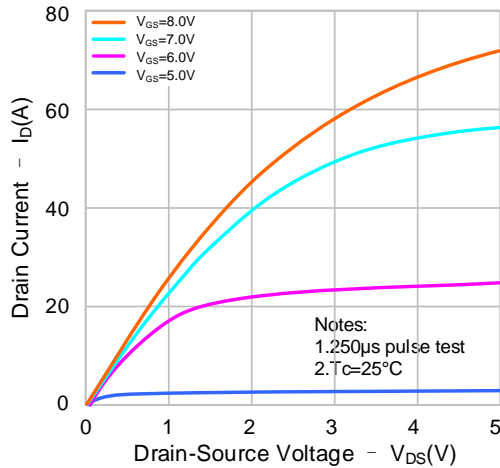


Figure 2. Transfer Characteristics

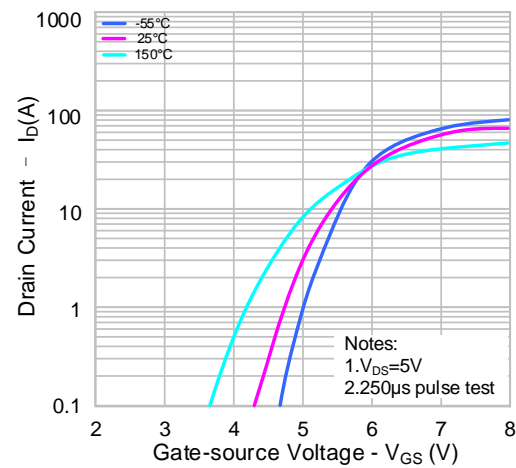


Figure 3. On-resistance vs. Drain Current

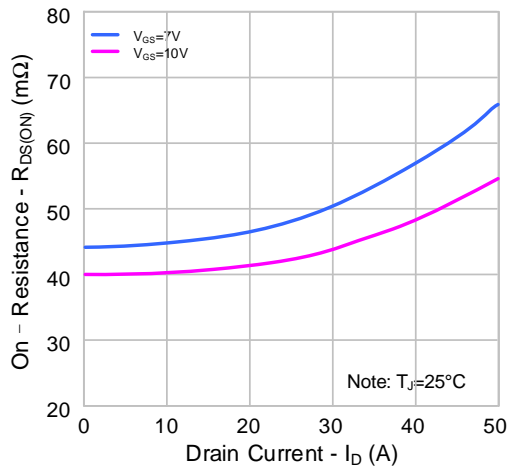


Figure 4. On-resistance vs. Gate-source Voltage

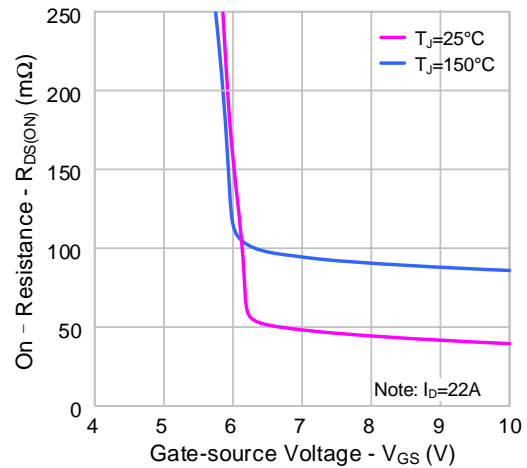


Figure 5. Gate-source Turn-on Voltage vs. Temperature characteristics

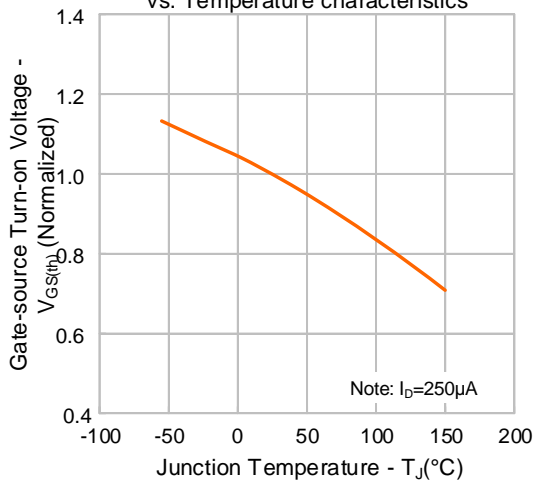
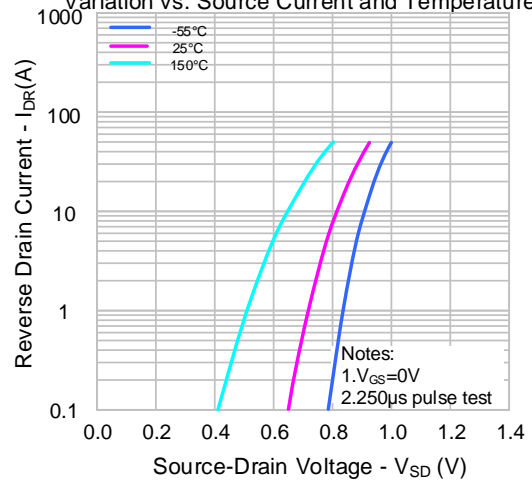
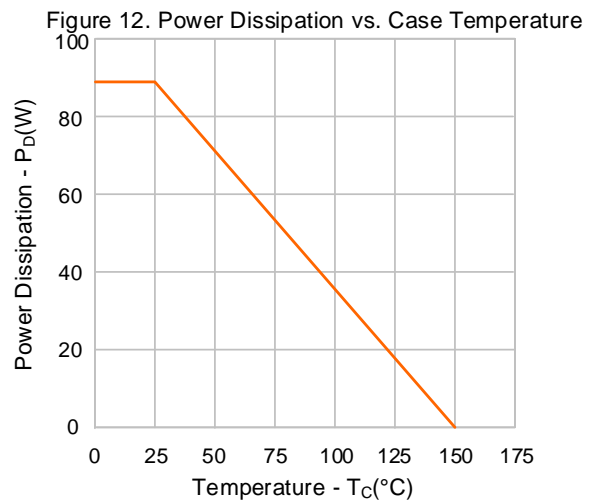
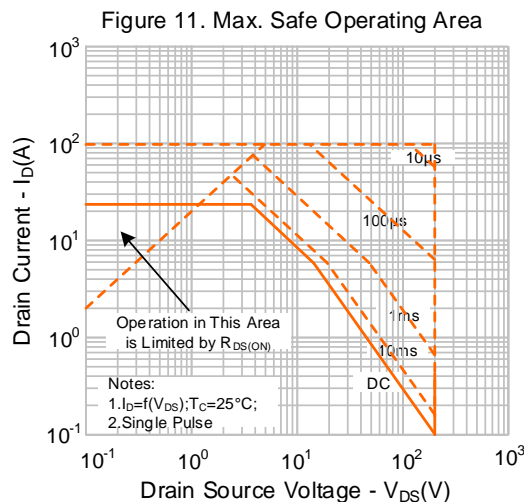
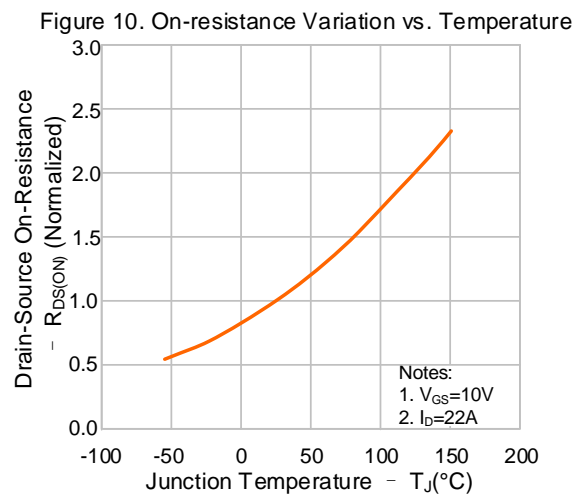
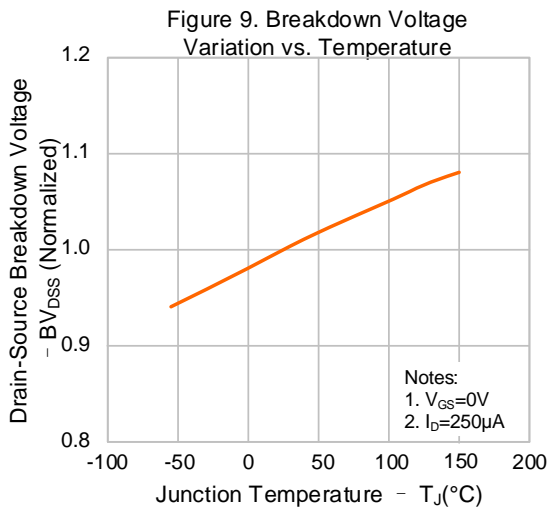
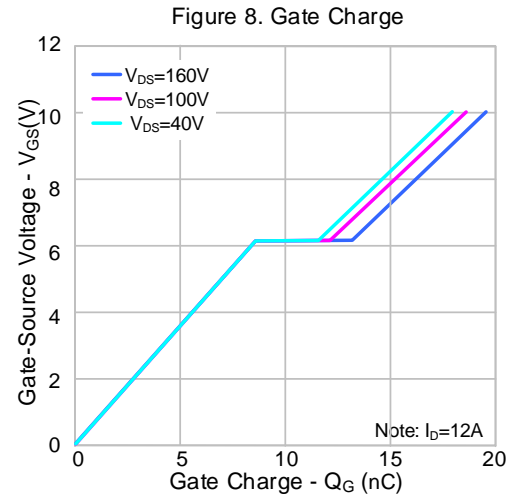
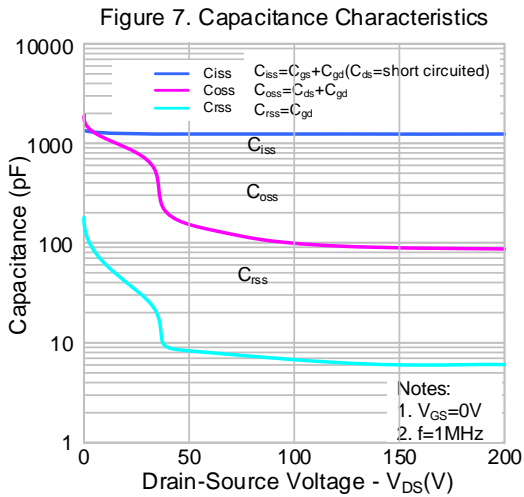


Figure 6. Body Diode Forward Voltage Variation vs. Source Current and Temperature



**TYPICAL CHARACTERISTICS (CONTINUED)**



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Figure 13. Max. Drain Current vs. Case Temperature

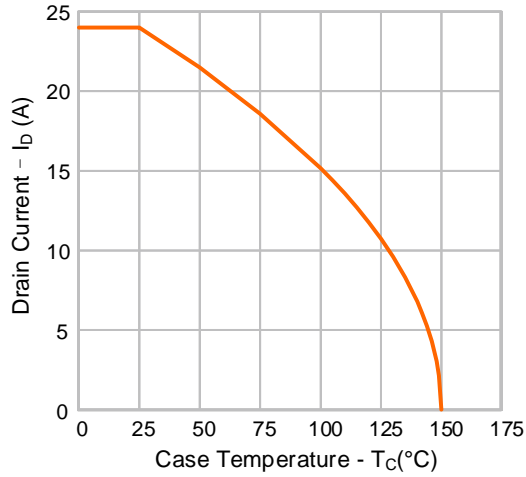
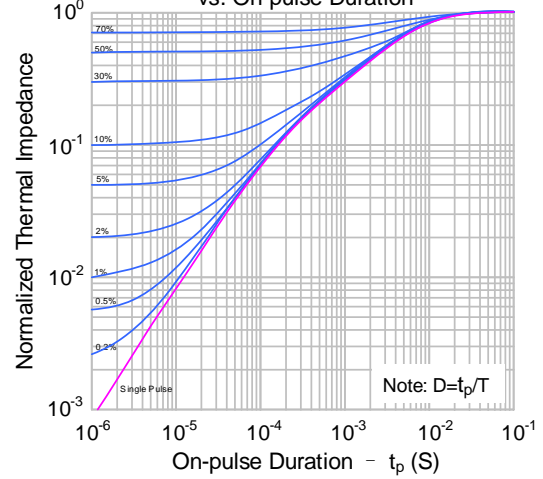
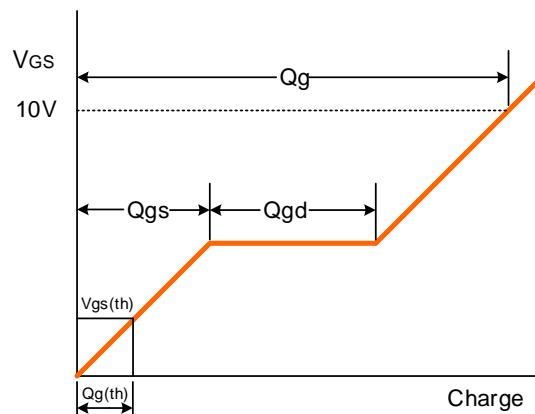
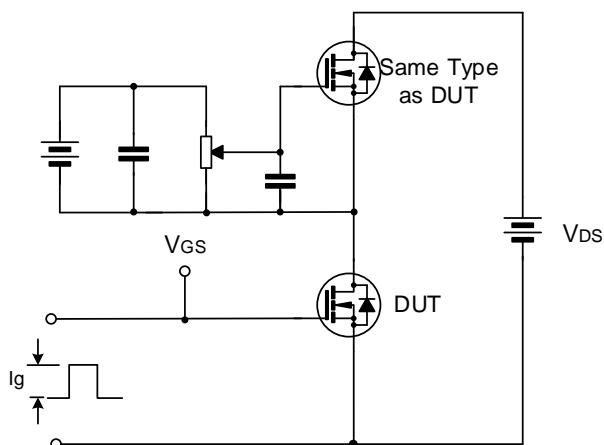


Figure 14. Transient Thermal Impedance vs. On-pulse Duration

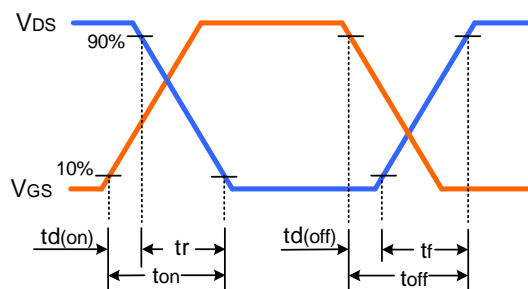
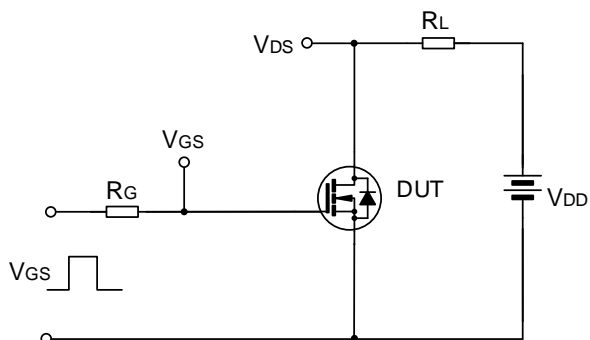


## TYPICAL TEST CIRCUIT

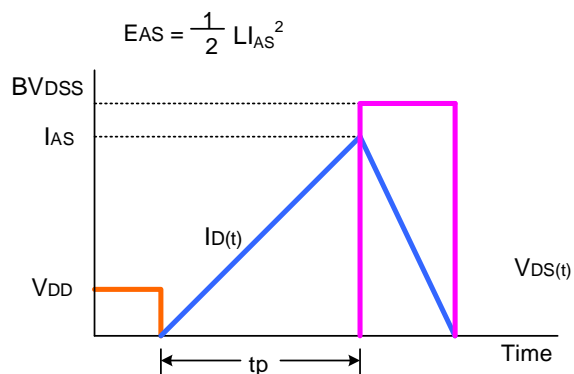
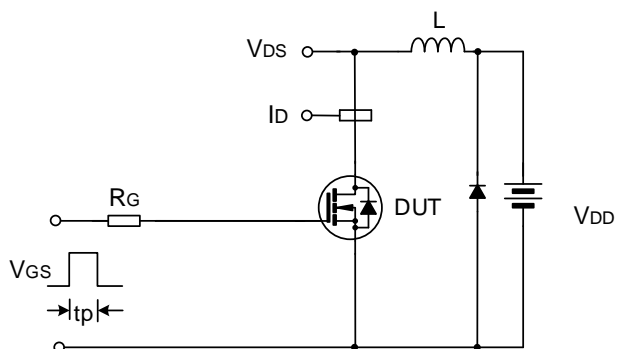
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



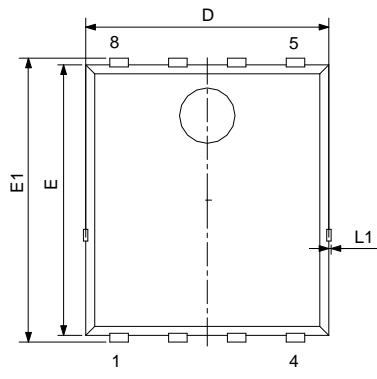
Unclamped Inductive Switching Test Circuit & Waveform



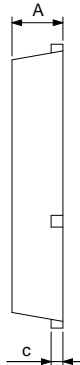
## PACKAGE OUTLINE

PDFN-8-5X6X0.95-1.27

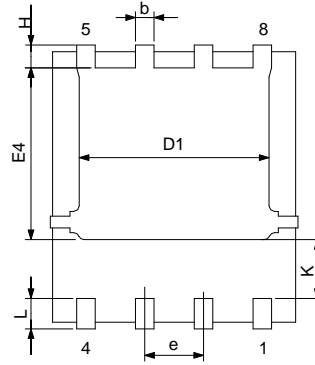
UNIT: mm



Top View



Side View



Bottom View

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	0.90	—	1.20
c	0.154	0.25	0.354
D	4.80	—	5.40
E	5.66	—	6.06
D1	3.76	—	4.30
E1	5.90	—	6.35
b	0.30	—	0.55
K	1.10	1.30	1.50
e	1.07	1.27	1.37
E4	3.34	—	3.92
L	0.30	0.60	0.71
L1	—	—	0.12
H	0.40	—	0.71



### MOS DEVICES OPERATE NOTES:

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.



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Rev.: 1.3

Revision History:

1. Delete the wave soldering condition
  2. Update the typical test circuit
  3. Update the important notice
- 

Rev.: 1.2

Revision History:

1. Update SOA
  2. Update typical test circuit
  3. Update important notice
- 

Rev.: 1.1

Revision History:

1. Modify electrical characteristics
  2. Update figure 5 and figure 11
  3. Add figure 13, 14
- 

Rev.: 1.0

Revision History:

1. First release
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